AMENDMENTS TO THE CLAIMS

Please amend claims 8, 20, and 34 as follows:

Claims 1-7 (cancelled).

Claim 8 (currently amended): An electrical test probe comprising:

a probe body;

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a probe tip mechanically coupled to said probe body, wherein said probe tip is capable of being non-permanently electrically coupled to an external test instrument:

a control device mechanically coupled to said probe body, and electrically isolated from said probe tip, wherein said control device is capable of being non-permanently electrically coupled to said test instrument; and

a mode display mechanically coupled to said probe body and electrically coupled to said test instrument visually representing a configuration of said test instrument.

Claims 9-12 (original).

Claims 13-19 (cancelled).

Claim 20 (currently amended): An electrical test probe comprising:

a probe body;

a probe tip mechanically coupled to said probe body;

a control device mechanically coupled to said probe body, and electrically isolated from said probe tip;

a communication port mechanically coupled to said probe body, and electrically coupled to said control device and said probe tip, wherein said communication

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port is capable of being non-permanently electrically coupled to an external electrical test instrument; and

a mode display mechanically coupled to said probe body and electrically coupled to said test instrument visually representing a configuration of said test instrument.

Claims 21-24 (original).

Claims 25-33 (cancelled).

Claim 34 (currently amended): An electrical test probe comprising:

a probe body;

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a probe tip mechanically coupled to said probe body;

a cable electrically coupled to said probe tip, mechanically coupled to said probe body, and non-permanently electrically and mechanically coupled to an external electrical test instrument;

a control device mechanically coupled to said probe body and electrically coupled to said cable, and electrically isolated from said probe tip, wherein said control device, when activated, activates a function of said test instrument; and a mode display mechanically coupled to said probe body and electrically coupled to said test instrument visually representing a configuration of said test instrument.

Claims 35-38 (original).